

Search Notes**Application/Control No.**

10/808,560

Examiner

Gopal C. Ray

Applicant(s)/Patent under Reexamination

OHNISHI, MAKOTO

Art Unit

2111

SEARCHED

Class	Subclass	Date	Examiner
710	305,313,3 00,33,110, 316	1/11/2006	GCR
715	735	1/11/2006	GCR
365	189.04	1/11/2006	GCR
711	155,203	1/11/2006	GCR
709	223,238	1/11/2006	GCR
709	208,213	1/11/2006	GCR
709	253	1/11/2006	GCR
370	434,230	1/11/2006	GCR
370	401,402	1/11/2006	GCR
370	351,257	1/11/2006	GCR
370	244,464	1/11/2006	GCR
370	492	1/11/2006	GCR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST: US PGPUB, USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB (see search history printouts)	1/10/2006	GCR
WEST: US PGPUB, USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB (see search history printouts)	1/11/2006	GCR
EAST: USPT (see search history printouts)	1/10/2006	GCR
NPL: IEEE Xplore (see search history printouts)	1/10/2006	GCR